



BSI Standards Publication

Semiconductor devices – Mechanical and climatic test methods

Part 18: Ionizing radiation (total dose) (IEC 60749-18:2019)

National foreword

This British Standard is the UK implementation of EN IEC 60749-18:2019. It is identical to IEC 60749-18:2019. It supersedes BS EN 60749-18:2003, which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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Amendments/corrigenda issued since publication

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